Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination SEBASTIAN ET AL. Examiner Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,554,969	09-1996	Eguchi, Takaaki	340/438
	В	US-4,939,653	07-1990	Tsurumiya et al.	701/41
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08282520 A	10-1996	Japan	FUSHIMI et al.	B62D 06/00
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į	Ρ					
	σ					
	R					
	Ø					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	×							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.